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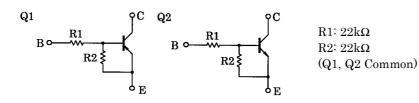
TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT Process) Silicon NPN Epitaxial Type (PCT Process)

RN4603

Switching, Inverter Circuit, Interface Circuit And Driver Circuit Applications

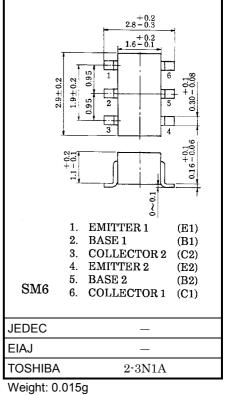
- Includeing two devices in SM6 (super mini type with 6 leads)
- With built-in bias resistors
- Simplify circuit design •
- Reduce a quantity of parts and manufacturing process

Equivalent Circuit and Bias Resister Values



Q1 Maximum Ratings (Ta = 25°C)

| Characteristic | Symbol | Rating | Unit |
|---------------------------|------------------|--------|------|
| Collector-base voltage | V _{CBO} | -50 | V |
| Collector-emitter voltage | V _{CEO} | -50 | V |
| Emitter-base voltage | V _{EBO} | -10 | V |
| Collector current | Ι _C | -100 | mA |



Q2 Maximum Ratings (Ta = 25°C)

| Characteristic | Symbol | Rating | Unit |
|---------------------------|------------------|--------|------|
| Collector-base voltage | V _{CBO} | 50 | V |
| Collector-emitter voltage | V _{CEO} | 50 | V |
| Emitter-base voltage | V _{EBO} | 10 | V |
| Collector current | Ι _C | 100 | mA |

Unit in mm

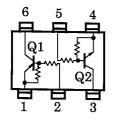
Q1, Q2 Common Maximum Ratings (Ta = 25°C)

| Characteristic | Symbol | Rating | Unit |
|-----------------------------|------------------|---------|------|
| Collector power dissipation | P _C * | 300 | mW |
| Junction temperature | Тj | 150 | °C |
| Storage temperature range | T _{stg} | -55~150 | °C |

* : Total rating

Marking

Equivalent Circuit (Top View)



Q1 Electrical Characteristics (Ta = 25°C)

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Тур. | Max | Unit |
|--------------------------------------|-----------------------|-----------------|---|-------|------|-------|------|
| Collector cut-off current | I _{CBO} | _ | $V_{CB} = -50V, I_E = 0$ | — | _ | -100 | nA |
| | I _{CEO} | _ | $V_{CE} = -50V, I_B = 0$ | — | _ | -500 | |
| Emitter cut-off current | I _{EBO} | _ | $V_{EB} = -10V, I_C = 0$ | -0.17 | _ | -0.33 | mA |
| DC current gain | h _{FE} | - | $V_{CE} = -5V, I_C = -10mA$ | 70 | _ | _ | |
| Collector-emitter saturation voltage | V _{CE (sat)} | _ | I _C = −5mA, I _B = −0.25mA | _ | -0.1 | -0.3 | V |
| Input voltage (ON) | V _{I (ON)} | _ | $V_{CE} = -0.2V, I_C = -5mA$ | -1.3 | | -3.0 | V |
| Input voltage (OFF) | V _{I (OFF)} | _ | $V_{CE} = -5V, I_C = -0.1mA$ | -1.0 | | -1.5 | V |
| Transition frequency | f _T | _ | V _{CE} = -10V, I _C = -5mA | _ | 200 | _ | MHz |
| Collector output capacitance | C _{ob} | _ | $V_{CB} = -10V, I_E = 0, f = 1MHz$ | _ | 3 | 6 | pF |

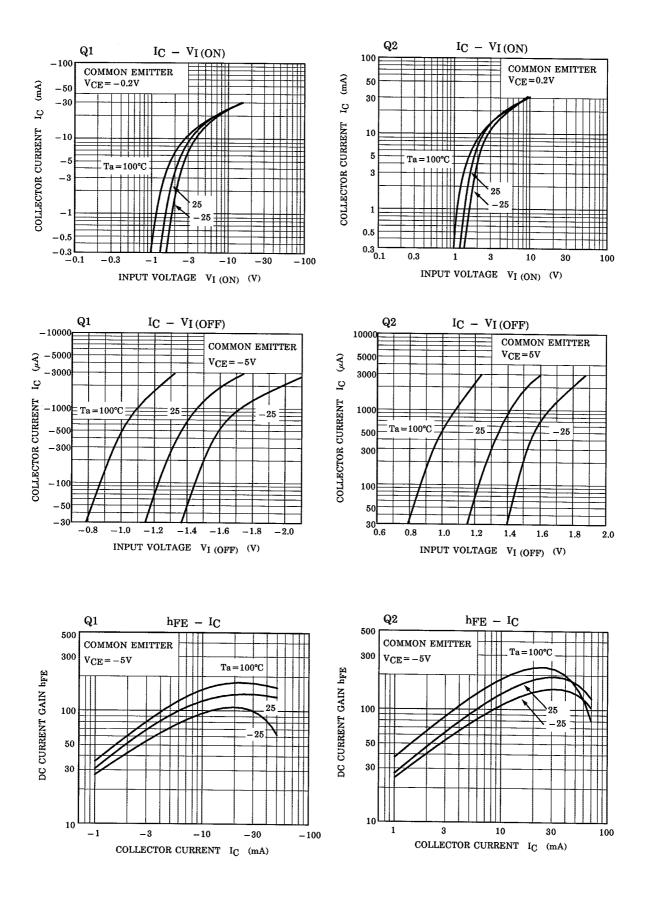
Q2 Electrical Characteristics (Ta = 25°C)

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Тур. | Max | Unit |
|--------------------------------------|-----------------------|-----------------|--|------|------|------|------|
| Collector cut-off current | I _{CBO} | - | V _{CB} = 50V, I _E = 0 | _ | _ | 100 | nA |
| | ICEO | _ | V _{CE} = 50V, I _B = 0 | — | — | 500 | |
| Emitter cut-off current | I _{EBO} | _ | V _{EB} = 10V, I _C = 0 | 0.17 | — | 0.33 | mA |
| DC current gain | h _{FE} | _ | V_{CE} = 5V, I_{C} = 10mA | 70 | — | — | — |
| Collector-emitter saturation voltage | V _{CE (sat)} | - | I _C = 5mA, I _B = 0.25mA | _ | 0.1 | 0.3 | V |
| Input voltage (ON) | V _{I (ON)} | _ | V _{CE} = 0.2V, I _C = 5mA | 1.3 | _ | 3.0 | V |
| Input voltage (OFF) | V _{I (OFF)} | _ | V _{CE} = 5V, I _C = 0.1mA | 1.0 | _ | 1.5 | V |
| Transition frequency | f _T | _ | V _{CE} = 10V, I _C = 5mA | _ | 250 | _ | MHz |
| Collector output capacitance | C _{ob} | — | V _{CB} = 10V, I _E = 0, f = 1 MHz | — | 3 | 6 | pF |

Q1, Q2 Common Electrical Characteristics (Ta = 25°C)

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Тур. | Max | Unit |
|----------------|--------|-----------------|----------------|------|------|------|------|
| Input resistor | R1 | _ | — | 15.4 | 22 | 28.6 | kΩ |
| Resistor ratio | R1/R2 | _ | — | 0.9 | 1.0 | 1.1 | _ |

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